

# **Processing and Interpretation of Momentum-Resolved Electron Energy-Loss Spectroscopy Data**

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## **Abstract**

Momentum resolved electron energy loss spectroscopy (MREELS) can provide a trove of valuable data about a specimen but often requires specialised and proprietary software to analyse. In this work Python methods that were designed for the analysis of MREELS data are explained and tested. This provided results consistent with earlier findings, namely the existence of the dispersionless  $3.5\text{eV}$ ,  $7.25\text{eV}$  and  $22\text{eV}$  energy loss peaks in the low momentum transfer region of the q-EELS spectral data. The dispersion of the bulk plasmon was also tracked along different crystallographic directions and found to potentially be anisotropic in the high momentum transfer regime.

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# 1 Introduction

Transmission electron microscopes are incredible machines capable of imaging structures at the atomic scale and can provide useful insight into the electronic properties of the sample being imaged.

The files produced by the transmission electron microscope are usually in a proprietary format and made to be analysed with specialised software that can often be expensive. Therefore this work will introduce some of the methods implemented in an open-source Python library, the methods to be discussed in this work are those that are used to analyse momentum resolved electron energy loss spectroscopy data sets. This work will use a data set procured by imaging a  $\gamma$ -indium selenide sample in an energy filtered transmission electron microscope set up for diffraction images.

The work starts by introducing all the necessary concepts in the theory section 2 such that his work can be understood without prior knowledge in the field of electron microscopy. In the experimental method section, chapter 3, a majority of the methods implemented will be presented and explained. The effect and usefulness of these methods are discussed in the results section, chapter 4. The work will be discussed, further intentions with respect to the software will be clarified and the final conclusion is presented in the conclusion chapter 5.

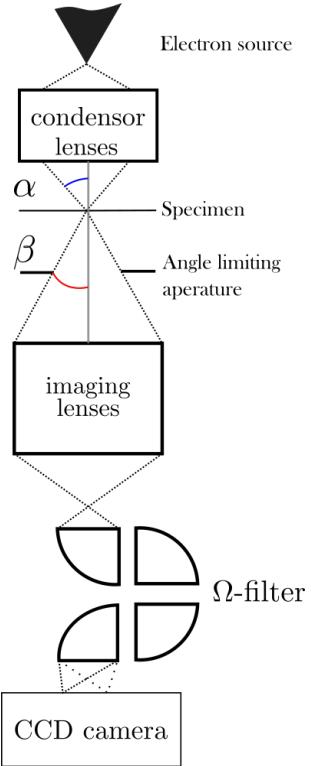


Figure 1: The optical column of the transmission electron microscope.

## 2 Theory

### 2.1 The Transmission electron microscope

The Transmission electron microscope (TEM) is a microscope that far exceeds the capabilities of a normal light microscope. Both types of microscope use a series of lenses to magnify the image of a specimen. A normal light microscope can amplify an image up to about  $1500\times$  and is limited by the diffraction limit of light. Assuming an average wavelength of  $550\text{nm}$  for green light, a high-end microscope is limited to resolving features  $100\text{nm}$  apart. This limit is insufficient for looking at atomic structures. [1]

An electron microscope circumvents this limit by using electrons, not light, to probe the specimen. Electrons when accelerated have a smaller wavelength than light thus allowing for images with resolved features as small as  $0.05\text{nm}$ . [2] The TEM works by releasing electrons from an electron source and accelerating them to an energy typically expressed in kilo-electronvolt. After being accelerated the electrons pass multiple electromagnetic lenses and a condenser aperture to shape the beam before it 'illuminates' the specimen as illustrated in 1. The beam incident on the sample is limited to a illumination semi-angle  $\alpha$  which is inversely proportional to the resolution, but limiting  $\alpha$  decreases the amount of electrons incident on the specimen and thus a frame needs more time for a exposure. After having interacted with the specimen the beam is again limited by an aperture, this aperture sets the collection semi-angle  $\beta$  which controls the limit of scattering angles allowed into the imaging lenses. After the beam is conditioned by the imaging lenses it passes trough four electromagnetic prisms which make up an energy filter called an  $\Omega$ -filter named after the shape it needs to have to keep the TEM stack aligned with the CCD-camera to limit aberrations. The  $\Omega$ -filter is used for the energy filtered TEM images discussed in section 2.4.1.

Two types of images can be made with the TEM, a normal image which shows the magnified sample and a diffraction pattern image which can be made by placing the capture device in the focal point of the lens and filter system. A diffraction mode image shows the diffraction peaks that are characteristic of the sample and yields information on the reciprocal lattice of the sample. [3]

## 2.2 Crystal structure

A crystal is build up of unit cells in such a way that the whole crystal can be made by shifting and aligning unit cells. These unit cells are build up of atoms whose position in the unit cell can be fully expressed in terms of primitive basis vectors. If the crystal were to be cut in half by a plane this plane would be expressed by fractional coordinates, these fractional coordinates show where along a basis vector the plane and basis vector intersect. Such a plane is called a Miller plane and the corresponding coordinates are called the Miller indices. Miller planes that have the same orientation but are shifted to different unit cells share the same Miller indices and are called a family of planes. The crystal structure of  $\gamma$ -IndiumSelenide with its basis vectors and unit cell is shown in figure 2. In reciprocal space the diffraction spots correspond to a certain family of planes, the position of diffraction spots can be expressed in reciprocal basis vectors. A reciprocal basis unit cell is shown in figure 3. In this figure the high-symmetry points are shown as well as the reciprocal basis vectors.

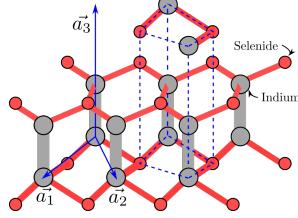


Figure 2: The crystal lattice of  $\gamma$ -InSe. The basis vectors are displayed as the blue arrows and a unit cell is outlined by the dashed blue box.

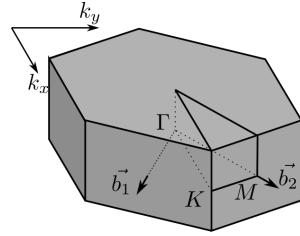


Figure 3: A reciprocal unit cell containing the high-symmetry  $\Gamma$ -,  $M$ - and  $K$ -points. The reciprocal lattice vectors are denoted by the  $\vec{b}_1$  and  $\vec{b}_2$  vectors.

## 2.3 Electron scattering theory

In a TEM setup electrons are essentially shot through a sample in which the electrons can either simply pass through or scatter, in the latter scenario there are two possibilities, electrons can scatter elastically or inelastically. Scattering is a result of the interaction between the sampling electrons from the TEM source and the charged particles in the specimen.

When scattering elastically the electrons interact with a nucleus of the specimen whose mass is many times greater than that of the sampling electron, resulting in a small and usually unmeasurable energy transfer. In a crystalline specimen electrons can only be scattered at certain angles due to the crystal structure creating a diffraction pattern of bright spots. In cases of large scattering angles the electron does transfer a significant amount of energy and can even reverse direction, this energy transfer can permanently displace atoms in the crystal structure causing a defect. [3]

When the sampling electron interacts with an electron in the specimen's crystal lattice inelastic occurs due to the similarity in mass between the two electrons. The energy transfer of this interaction ranges from a few electronvolts up to multiple hundreds of electronvolts. Inelastic scattering not only results in an energy transfer but also in a momentum transfer as shown in figure 4, the  $k'$ -vector shows a scattered electron that deviates from the not scattered electron vector  $k_0$ . The total momentum transfer is the sum of the perpendicular momentum transfer  $q_{\perp}$  proportional to the scattering angle  $\theta$  and the momentum transfer parallel to the undisturbed path due to an energy transfer from the sampling electron to the sample. This parallel momentum transfer is thus proportional to the energy loss of the electron. Figure 5 shows the band structure of the crystalline sample of which the electrons scatter. In this figure two dispersion bands are shown, both bands can be occupied by electrons of certain energies, to excite an electron from the blue band to the red band an electron needs either energy (path  $t_1$ ) or energy and momentum (path  $t_2$ ). The needed energy and momentum are transferred from an incident sampling electron in the inelastic interaction. By measuring the energy and momentum of a scattered electron it is possible to piece together all the combinations of energy and momenta transfer possible and thus find the band structure of the sample.

Another form of inelastic scattering is plasmon excitation.

Since the outer-shell electrons of an atom are only weakly bound to the nucleus due to screening effects but are coupled together by electrostatic interaction. These delocalised electrons form an energy band similar to that shown in figure 5. When a fast-moving sampling electron is shot through the sample all

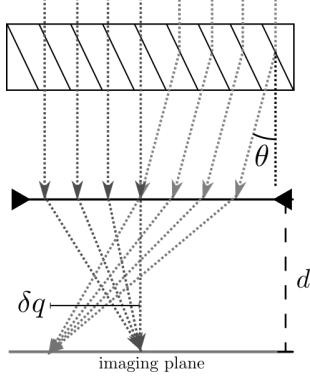


Figure 6: The focusing of scattered electrons on the imaging plane in discrete momenta transfers.

nearby outer-shell electrons are displaced. If the sampling electron's velocity exceeds the fermi speed the displacement of outer-shell electrons creates an oscillating ripple creating waves of alternating positive and negative electric charge, this is known as a plasmon wake. [3]

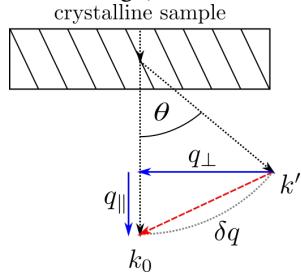


Figure 4: The elastic scattering  $k'$  of an electron over an angle  $\theta$  due to the interaction with a crystalline sample.

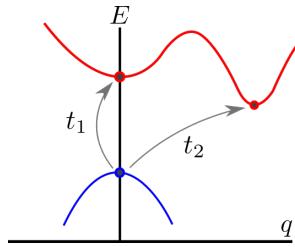


Figure 5: The band structure of the crystalline sample in fig. 4 showing both a direct bandgap  $t_1$  and an indirect bandgap  $t_2$ .

## 2.4 Momentum resolved electron energy-loss spectroscopy

Momentum resolved electron energy-loss spectroscopy hereafter abbreviated as MREELS is a TEM imaging technique in which the imaging plane of the CCD camera is placed in the focal point of the imaging lenses and energy filter. This allows the camera to take a diffraction mode image in which the diffraction pattern of the scattering electrons is shown. This is illustrated in figure 6. In this figure the crystalline sample is shown as the box with the slanted lines that represent the Miller planes of the crystal structure. As shown in the figure all electrons that scatter off of the same family of Miller planes get focused on the same region on the imaging sensor, electrons that do not scatter also get focused in one spot at the centre of the diffraction pattern. A diffraction mode image does not image normal space but instead shows reciprocal space which is also the reason this type of image is useful. In a normal image one would attribute lengths to the axes of an image but in a diffraction mode image the separation of features is given by a momentum difference. The separation of the light and dark grey arrows on the imaging plane in figure 6 is thus equal to the difference in perpendicular momentum transfer between scattering electrons (light grey) and electrons that do not scatter (dark grey), a 3D representation is presented in the Appendix. Since the momentum transfer for the electrons that do not scatter is zero the momentum transfer for scattering of a certain family of planes can be determined.

### 2.4.1 Energy filtered transmission electron microscope

An energy filtered transmission electron microscope is a microscope with an energy filter placed in the optical column of the TEM. Energy filtering is accomplished by the use of electromagnetic prisms such as those shown in figure 8. These prisms just like ordinary prism disperse the electrons with different wavelengths which are proportional to electron energy. By sliding a slit into the cone of dispersed electrons it is possible to choose a finite range of electron energies to image. The EFTEM setup can be used in

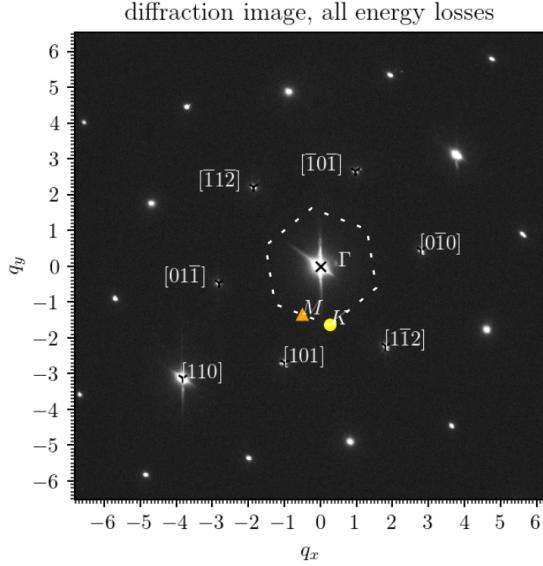


Figure 7: A diffraction mode image showing the total scattering intensity at momentum space positions. The diffraction spots are indexed with Miller indices. The  $M$ - and  $K$ -point and first Brillouin zone are also shown.

conjunction with the MREELS imaging technique to gather information on both the momentum transfer of the electron (via MREELS) and the energy loss associated (via EFTEM) with that momentum transfer.

## 2.5 Diffraction image

In a diffraction mode image a set of bright spots for which scattering probability is high is present in momentum space. These bright spots correspond to a family of planes, to determine to which family of planes the bright spots correspond they first have to be indexed. Indexing is done by using the geometric properties of the image to narrow down how the image is oriented. By measuring the distance from the middle brightest spot to one of the closer outward ones, measuring the angle between lines connecting these spots and searching for these values in a database it is possible to determine to zone and orientation of the image<sup>1</sup>. Once the image is indexed the family of planes can be attributed to the bright diffraction spots as done in figure 7.

## 2.6 q-EELS spectra and q-EELS map

An electron energy loss spectroscopy spectrum is a plot that show the scattering intensity at a certain energy loss  $\Delta E$  of the electron, a q-EELS spectrum also has a momentum transfer value  $q_{\perp}$  that corresponds to the whole spectrum. A q-EELS spectrum is plotted in figure 9, this spectrum corresponds to a momentum transfer of zero and is thus in the middle of the centre diffraction spot. The spectrum starts with a high peak in the low-loss region, this peak is called the zero-loss peak and shows the high intensity of electrons not losing energy and in this case momentum when passing through the sample. This peak is a problem since it masks the interesting low-loss data completely.

The q-EELS map shows the same energy loss spectra but for multiple momenta transfers at a time. For every combination of energy loss and momentum transfer there is a single intensity value which is shown in colour, the brighter the pixel the more electrons scatter with that combination of energy loss and momentum transfer. A q-EELS map is pictured in figure 10, the zero-loss peaks still show as the bright streak at  $\Delta 0eV$  for all momenta transfers. This spectrum was created by walking the path from  $\Gamma$  to  $M$  and then to  $K$  in which the points are the same as in figure 7.

<sup>1</sup>A huge thank you to A. Brokkelkamp for showing how to index the diffraction image

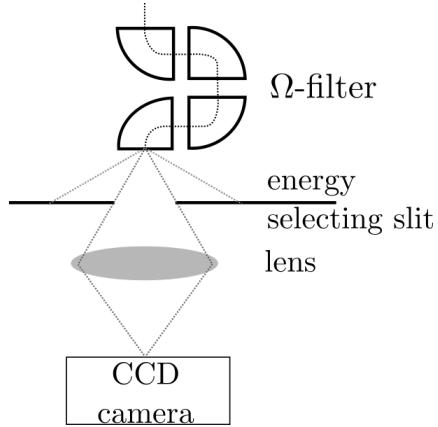


Figure 8: A  $\Omega$ -spectrometer spreading the electrons based on their energy and a slit selecting energies to focus on the CCD camera.

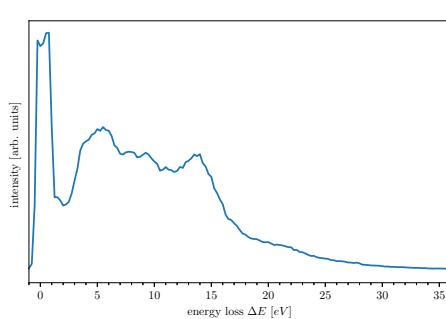


Figure 9: A q-EELS spectrum of  $\gamma$ -InSe for  $q_{\perp} = 0$

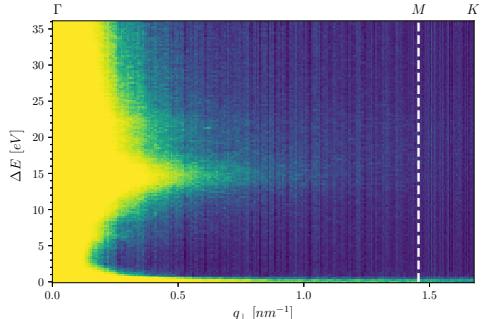


Figure 10: A q-EELS map of  $\gamma$ -InSe along  $\Gamma \rightarrow M \rightarrow K$

## 2.7 Physical relevance of (MR)EELS data

As hinted at in section 2.4, the combination of both energy and momentum information allows for the reconstruction of the band structure of the specimen. This information can be used to determine the density of states of the specimen [4] [3]. EELS spectra can also be used to determine the electronic properties of the specimen, the bandgap of a semiconductor and the dielectric function, as well as mechanical properties [3]. Different signature peaks in the EELS data can be used to determine the elemental makeup of the specimen [3].

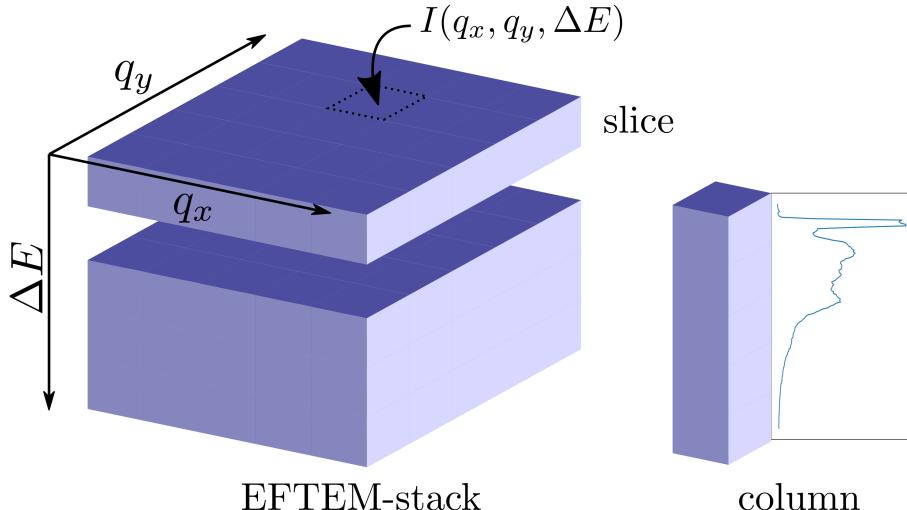


Figure 11: An illustration of an EFTEM-stack, slice, column and corresponding axes.

### 3 Experimental Method

#### 3.1 Data format

For this work a specimen of  $\gamma$ -InSe was imaged using the momentum resolved electron energy loss technique in an energy filtered transmission electron microscope. The file was supplied with aligned zero-loss peaks in Gatan's .dm4 format which had to be converted to a python object for further data processing in python, for the conversion from Gatan's proprietary file to a python object the excellent ncempy package was used. [5]

The measurement data is gathered by taking energy filtered diffraction images at different energy losses. All these images are stacked corresponding to their energy loss value, resulting in a EFTEM image stack as illustrated in figure 11. In the illustrated cube the horizontal planes or slices are diffraction mode images associated with an energy loss  $\Delta E$ , these energy slices have their own momentum axes that are not necessarily aligned with the whole stack. After alignment the individual pixels in the EFTEM stack can be fully expressed by four values, three coordinates:  $q_x$ ,  $q_y$ ,  $\Delta E$  and one scattering intensity  $I$ .

An example of such a spectrum is illustrated in figure 9. Another way is to extract multiple of these columns such that their total momentum increases, doing this yields a energy-momentum map as pictured in figure 10. Once the EFTEM stack is aligned it is possible to start extracting sets of values in meaningful ways. One way is to take a single column from the top of the stack to the bottom, doing this results in a 1D-array of values for a set position in momentum space and varying energy-loss, this is called an electron energy loss spectrum.

#### 3.2 Data correction techniques

##### 3.2.1 Removing/altering values

Before any meaningful results can be extracted from the EFTEM stack it is important to first correct the data. This process starts by removing all the values corresponding to negative energy losses, these values are incorrectly indexed as a result of the microscope software aligning the slices such that the zero-loss peak is at an energy loss of 0eV. It does this by shifting slices up or down to match them to their true energy loss, slices corresponding to negative energy losses are duplicates of slices at positive energy losses. After removing the negative energy loss slices the negative intensity values are raised by the minimum amount needed to make all values positive. This means that all values of the entire stack are raised by the absolute value of the most negative intensity. Doing this changes the performance of further techniques for the better.

Since the acquisition time of the EFTEM stack is quite large and not all slices are taken at the same time

it might happen that the sample moves due to disturbances. Correcting this is done by convoluting a slice with Sobel matrices to get an edge-detected image, these images are then aligned by means of Fourier phase correlation [6].

### 3.2.2 Zero-loss peak and Batson correction

To try and remove the zero-loss peak of the q-EELS spectrum a Batson correction is performed. A Batson correction normally uses the sum of all EELS spectra in an EFTEM image of the sample to try and correct plural scattering and subtract the zero-loss peak [7]. Since such an image is not available the sum of all q-EELS spectra in the first Brillouin zone is used instead. This region was more likely to correspond to a true image of the sample, the sum of the q-EELS spectra in the first Brillouin zone is called the correction spectrum. The Batson correction is then performed by scaling the correction spectrum for each q-EELS spectra to be corrected in such a way that the integrated intensities of the zero-loss peaks match, then the "centre of intensity" of the zero-loss peaks is determined and the correction spectrum is subtracted from the to be corrected q-EELS spectra with the centres of intensity aligned. The Batson correction code was rewritten in python after being originally written in DigitalMicrographs scripting language for an earlier work. [8].

## 3.3 Data processing techniques

Since the EFTEM data is essentially a 3D cube of values it needs to be processed in such a way that the information it contains can be extracted and interpreted. This is something that can not be done with the cube itself since it is hard to represent 3D data in meaningful ways.

### 3.3.1 Integration techniques

To achieve the goal of representing the data in a meaningful ways two integration techniques have been implemented in Python. A radial integration method that finds the centre of the image stack which is determined to be the brightest pixel of the unaltered EFTEM stack. Since this is most probably the zero-loss peak at the centre of the unscattered beam. From this centre outward the method sums all EELS spectra in circle from a certain radius to that radius plus a ringsize, the starting and ending radius as well as the ringsize can be specified by the user. This method is the same as averaging over nearby momenta transfers. When this method is finished the result is an array of summed EELS spectra for a set of rings. This can be plotted as a momentum-energy EELS map as shown in figure 10. Instead of integration in circle segments over the entire stack the user might want to only do a line-like integration towards a single diffraction peak. If this is the case a similar method to the one described above is called except for the change that instead of circle segments in integrates over pie piece like segments.

### 3.3.2 Slicing techniques

Slicing refers to the term of "array slicing" in Python/Numpy [9] which is the built-in way to select data from an array whose position in the array satisfies a condition. The slicing technique allows the user to specify one or two points and extracts all columns along the line between the two points. If one point is specified by the user the other point will be the centre of the EFTEM stack. This method returns an array of all the EELS spectra for the points along the line. This can again be plotted as a momentum-energy map.

## 3.4 Data extraction

Once the full 3D EFTEM stack is reduced to useful momentum-energy maps or *q*-EELS spectra it is possible to start identifying interesting features such as peaks in the *q*-EELS spectra at certain regions or bright spots in the momentum-energy maps. For instance, if long bright streaks can be observed in the momentum-energy map they might hint at a relation between energy and momentum of an often occurring reaction. One of such bright streaks that is present and will be tracked is the plasmon peak at roughly 14.5eV energy loss.

## 4 Results

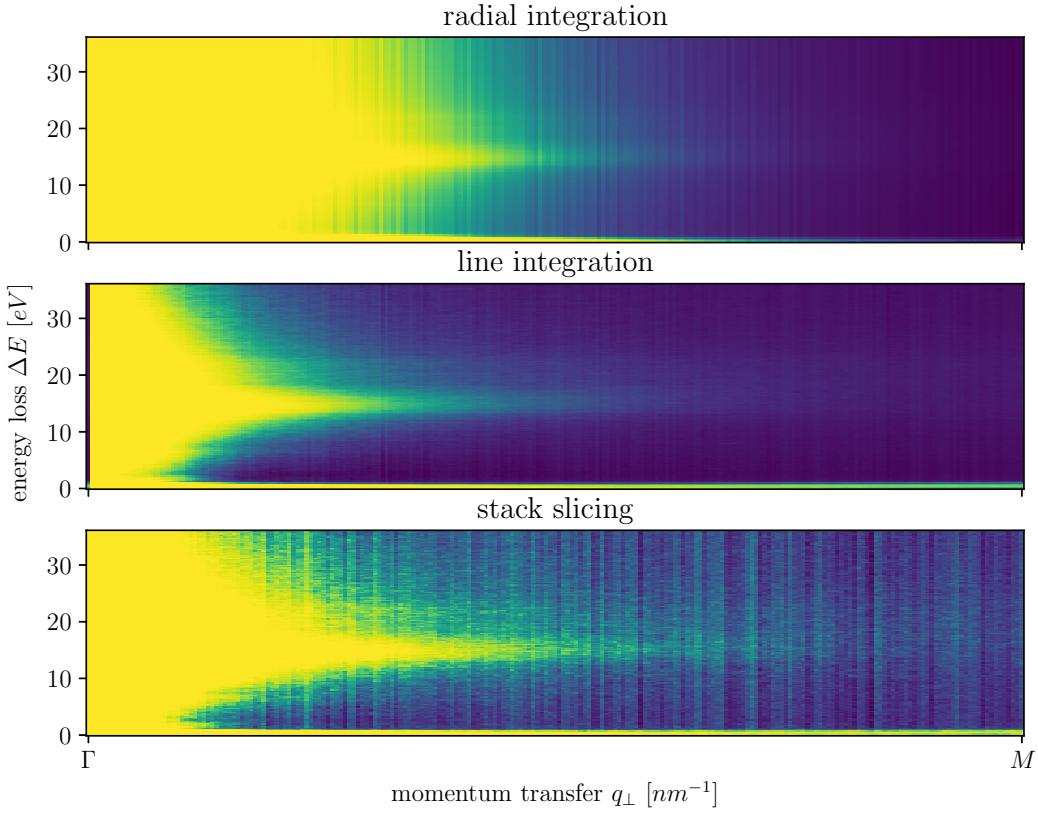


Figure 12: comparing various ways in which the q-EELS data can be extracted from the EFTEM stack

### 4.1 Comparing data extraction techniques

In figure 12 three different q-EELS maps are plotted, the radial, linear and slicing technique from top to bottom respectively. It is immediately obvious that the radial and linear "integration" techniques have higher resolutions along the momentum transfer axis. This is due to the fact that slicing the EFTEM stack between two points yields a pixelated line, similarly to opening paint and drawing a line, whereas the integration techniques also extract information from pixels just besides the line between two points resulting in smaller momentum transfer steps. One drawback to these techniques is that they also add intensity values from pixels not directly between to diffraction spots to the q-EELS map, this is especially so with the radial integration technique that uses all values on a circle outwards from the starting point. The integration techniques also yield a smoother gradient from low- $q_{\perp}$  to high- $q_{\perp}$  since it averages multiple q-EELS spectra in a ringsize, this again might introduce spectra not truly on the line in between two points but does average out any unwanted errors such as external radiation.

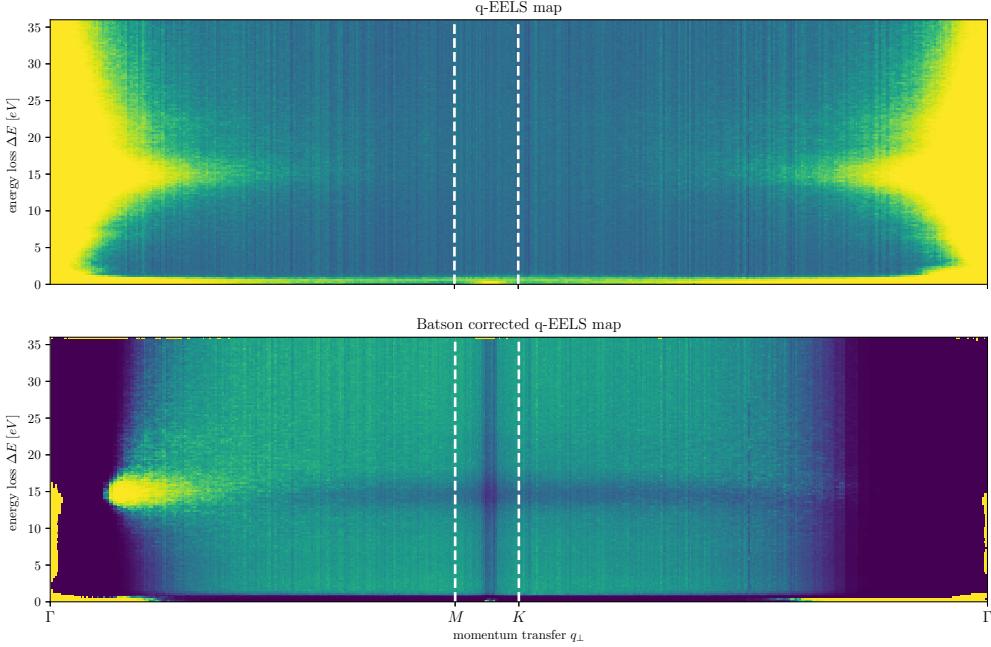


Figure 13: Batson correction for q-EELS map

## 4.2 Reviewing Batson correction

Carrying out the Batson correction on the sliced q-EELS map of the  $\Gamma$ -InSe sample in the  $\gamma \rightarrow M \rightarrow K$ -direction we can clearly see it has a big effect on the map. The q-EELS spectra near the low momentum transfer  $\Gamma$ -point are nearly fully erased. This was to be expected as it was also reported by earlier work. [10] Amplifying this region was not the intention of applying the Batson correction since the original EFTEM stack's data was sufficient. The high momentum transfer region near the high symmetry  $M$ - and  $K$ -points has benefitted from the correction, the q-EELS spectra had their zero-loss peaks removed and contrast heightened making it easier to resolve features in these spectra.

An apparent but not unexplainable feature or artefact of the correction is the dark band in the middle between the  $M$ - and  $K$ -points. The original q-EELS map (top figure in 13) had a bright spot in the middle of the zero-loss peak at the same position, the Batson correction uses an integral of the intensity over the zero-loss peak to scale the to be subtracted correction spectrum. Thus if there is an extra bright feature in the zero-loss peak the correction spectrum gets improperly scaled to be too large for what it needs to correct for and will upon subtraction remove too much intensity from the rest of the spectrum.

Another dark shadow can be seen spanning the whole momentum transfer range at about 14eV energy loss. This darker streak seems to curve upwards towards the middle and come back down, trailing nearly perfectly the bulk plasmon dispersion. This streak can not be explained by the subtraction since it curves upwards and the correction spectrum is subtracted centred around the zero-loss peak which curves downward towards negative energy losses.

The zero-loss peak itself is removed nicely from the q-EELS map for a majority of the momentum transfers. The Batson correction seems to leave a bit of the zero-loss peaks for moderately low momentum transfers. This could be due to the fact that the Batson correction uses a simulated image spectrum for its correction which underrepresents the zero-loss peak. A simulated image spectrum is used for the reasons outlined in 3.2.2 and might not be accurate enough as Batson himself reported in his work [7]. It could also be that the sum of smaller intense dispersions remains in the low-loss region. This would be hard to tell without a higher energy resolution.

Some more Batson corrected q-EELS maps have been included in the appendix 17.

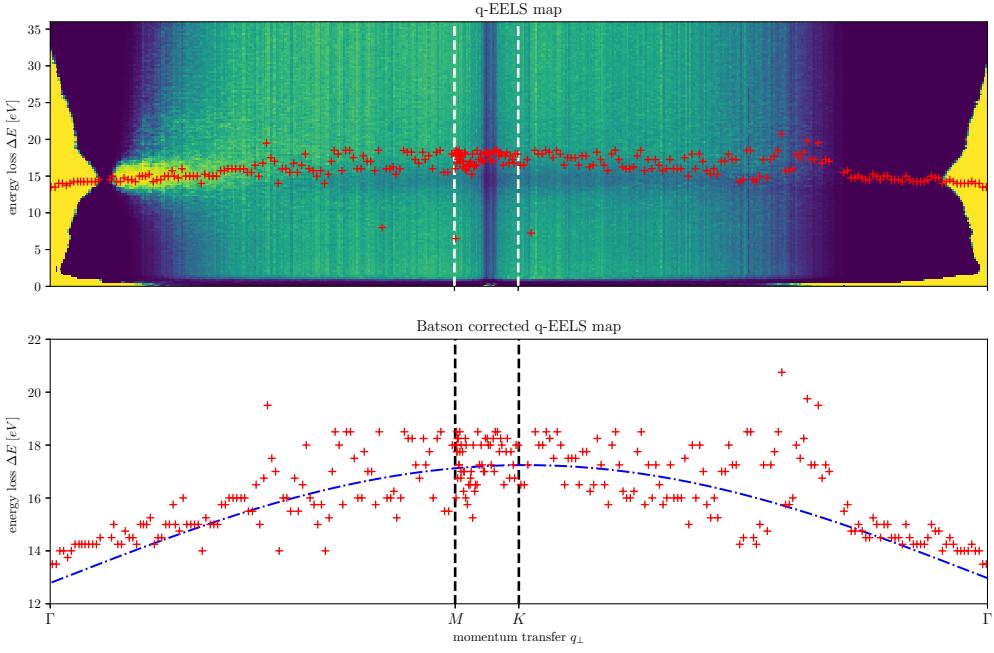


Figure 14: tracked peaks on stitched q-EELS map

### 4.3 Interesting features from data

For tracking the peak of the bulk plasmon a high enough separation between the peak and background spectrum was needed. The q-EELS map in figure 14 was made by stitching together the uncorrected q-EELS map in the low momentum transfer regime and the Batson corrected q-EELS map for high momenta transfers. The q-EELS data was gathered using the slicing method from the  $\Gamma$ -point to  $M$ , then  $K$ , and back to  $\Gamma$  with the definition of the points the same as earlier q-EELS maps and consistent with figure 7. The energy loss value of the plasmon peak was found by searching for the highest intensity value in a window around a centre energy loss value, this method does not always find the true peak as the outliers both far above and below the central point cloud show. The values for the peak of the plasmon were scrubbed from outliers and plotted in the bottom plot of figure 14, a sine centred around the point in the middle of the  $M$  and  $K$  lines was fitted and provides a decent result around the middle but deviates from the true function at the  $\Gamma$ -lines.

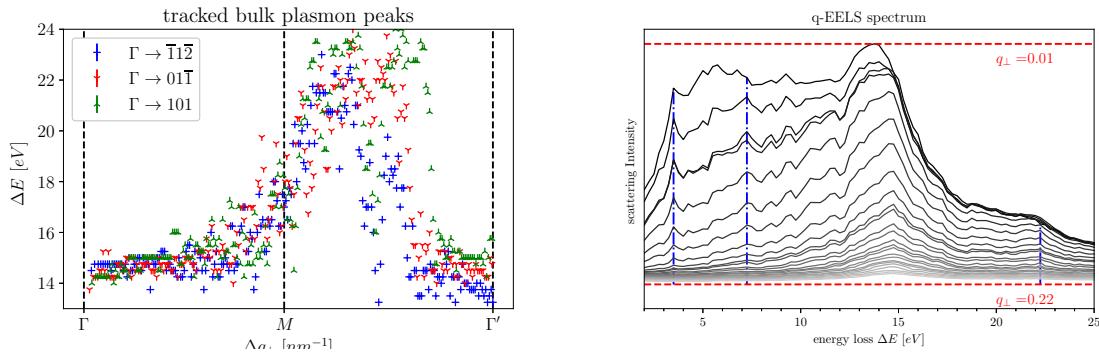


Figure 15: tracked peaks of the plasmon dispersion.

Figure 16: various tracked peaks not showing any dispersion.

To see whether the bulk plasmon dispersion is the same for multiple directions the line integration method was used to gather the q-EELS data. The path is taken from the centre diffraction spot  $\Gamma$  to the

$M$ -point and finally to  $\Gamma'$  which is the diffraction spot noted in the legend. The q-EELS data was not Batson corrected. As can be seen in figure 15 the dispersion of all the peaks seem to be somewhat similar at the start but diverges about halfway between the  $M$ - and  $\Gamma'$ -point, where the green and blue traces are highest and lowest respectively with red in between possibly hinting at the fact that the plasmon dispersion is anisotropic at high momenta transfers.

The bulk plasmon peak is not the only peak that can be tracked. However from all the peaks that were clear enough to track it was the only one that showed any dispersion. As can be seen in figure 16 there are three peaks that can be seen in the low momentum transfer region. These peaks at  $3.5\text{eV}$ ,  $7.25\text{eV}$  and  $22\text{eV}$  energy loss can be seen at the same position across momentum transfers meaning that they do not disperse. Peaks at these energy loss values have also been seen not dispersing in earlier literature [8] where indium selenide was studied using angle-resolved photoemission spectroscopy.

## 5 Conclusion

This work set out to introduce the reader to existing methods implemented in Python and validate the results with other earlier works.

From the data extraction techniques that were applied to the EFTEM stack the least useful one appeared to be the radial integration method since it was unable to isolate data in a single crystallographic direction. The other two extraction techniques are both useful for different purposes, the line integration technique was able to pool EFTEM columns of similar momentum transfer well and thus improved the momentum resolution of the q-EELS map whilst allowing the introduction of some data not truly in line with the crystallographic direction to be analysed. The stack slicing method delivered the 'purest' data but did so at the cost of momentum transfer resolution, the lack of pooling similar EELS spectra also reduced the signal with respect to the inherent background noise.

The zero-loss peak subtraction applied by the means of a Batson correction was useful for increasing the contrast of the data at the high momentum transfer region and was able to remove the zero-loss peak. Keeping in mind that the Batson correction needs an image spectrum to reach its desired accuracy, which was not available, the result were sufficient for tracking the relatively obscure plasmon peak in the high momentum transfer regime.

The analysed EFTEM stack showed similar features to those found in earlier works looking into the band structure of Indium Selenide, the low momentum transfer q-EELS spectra showed dispersionless peaks at energy-loss values similar to those found before. The bulk plasmon peak starting at roughly 14eV energy loss was successfully tracked between diffraction spots and showed some anisotropic behaviours.

Overall the results agree with earlier implementations of the methods applied, the results would benefit from a higher energy resolution to give the methods more information to work with. The Python methods developed for this work will continued to be worked on.

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## Appendix

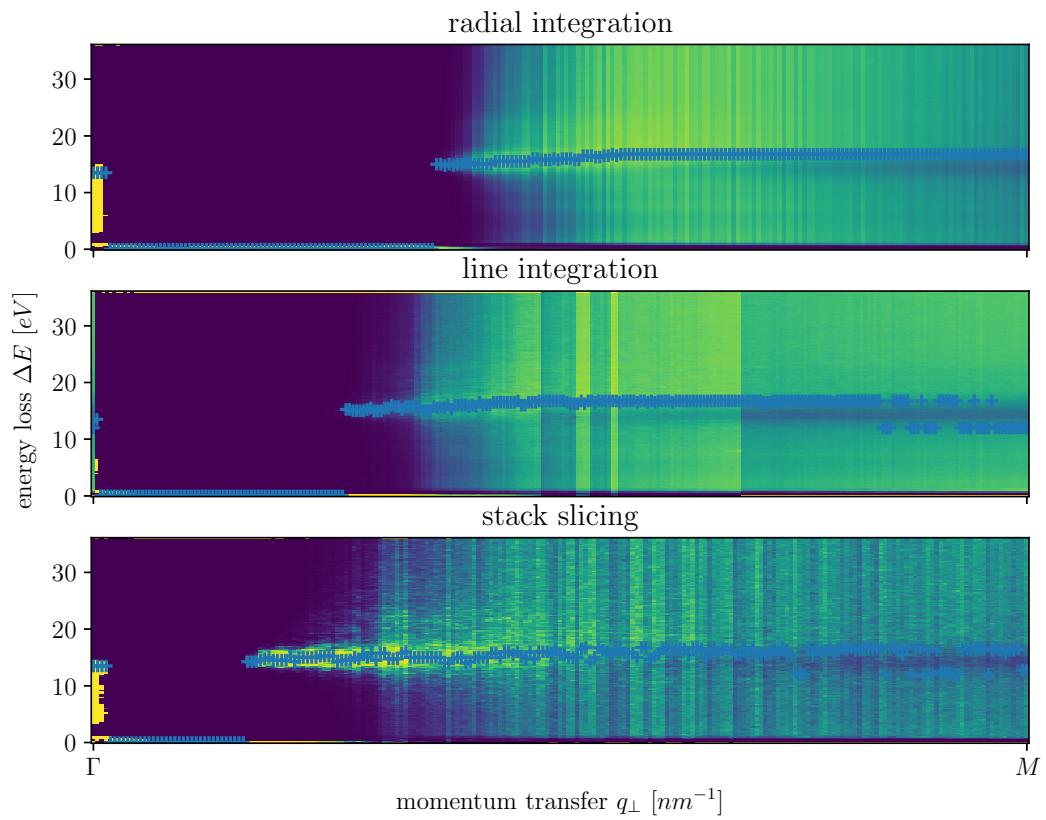


Figure 17: Batson correction applied to q-EELS maps constructed by different methods. The tracked plasmon peaks are denoted by the blue plusses.

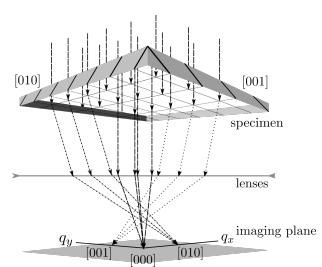


Figure 18: scat